


Hassan K. Reghbati is an assistant professor of computer science at Simon Fraser University in British Columbia. His research interests are in VLSI testing, computer graphics hardware, and software testing. A senior member of the IEEE, he has been active professionally, serving on the program committee of major conferences, as a consultant to industry, and as a member of standards committees.

Reghbati studied engineering physics at Arya-Mehr University of Technology in Iran, physics at MIT, and electrical engineering at University of Toronto. He is the guest editor of the special issue of the International Journal of Computers & Mathematics on “Diagnosis and Reliable Design of VLSI Systems.”

Reghbati’s address is School of Computing Science, Simon Fraser Univ., Burnaby, BC V3A 1S6 Canada.

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